

## Mtbf Analysis Of The Two-Unit Series System With Repair Facility

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### Abstract:

This paper discusses mean time between failure and availability analysis in a two-unit series repairable system with three states under consideration. First two states are taken as up states and the third state is down state. A single repair facility is available which repairs the units on first-come-first-serve basis. Taking failure rates as identically distributed exponential random variable and repair rate as exponential, Mean time between failure and Steady State Availability are calculated. Denoting the failure times of the components as  $\lambda$  and repair time as  $\mu$  expression for steady state availability and MTBF have been derived using semi-markov process and regenerative point technique. The difference equations are developed and solved using Laplace transform.

**Keywords:** Series System, Steady State Availability, MTBF, Semi-markov process, Regenerative point technique, Difference Equation, Laplace Transform.

### Introduction:

Two-unit standby repairable system has been discussed by many authors under different assumptions in the past. To name a few authors such as Gray and Lewis (1967) , Butterworth and Nikolaison (1973), Lie et al (1977), Osaki et al (1980), Klein and Moeschberger (1986), Joshi and Dharmadhikari(1989), Goel and Shrivastava(1991). All these authors have

evaluated reliability parameters for two-unit standby repairable system by taking different set of distributions. In the present paper, we have considered a two-unit series standby system under the assumption that whenever any working fails it is immediately taken over by standby unit. There is a single repair facility so that the repair work is started as soon as any unit fails.

We define the reliability of any system as  $R(t) = p_0(t) + p_1(t)$  and we are interested in calculating the values of  $p_0(t)$  and  $p_1(t)$  for which we employ the techniques of obtaining differential equations satisfied by

$p_i(t)$ ,  $i= 1,2$  and making the use of Laplace transform and Cramer's rule and using the formula for MTBF as

$$MTBF = \int_0^{\infty} R(t) dt$$

**System Description and Assumptions :**

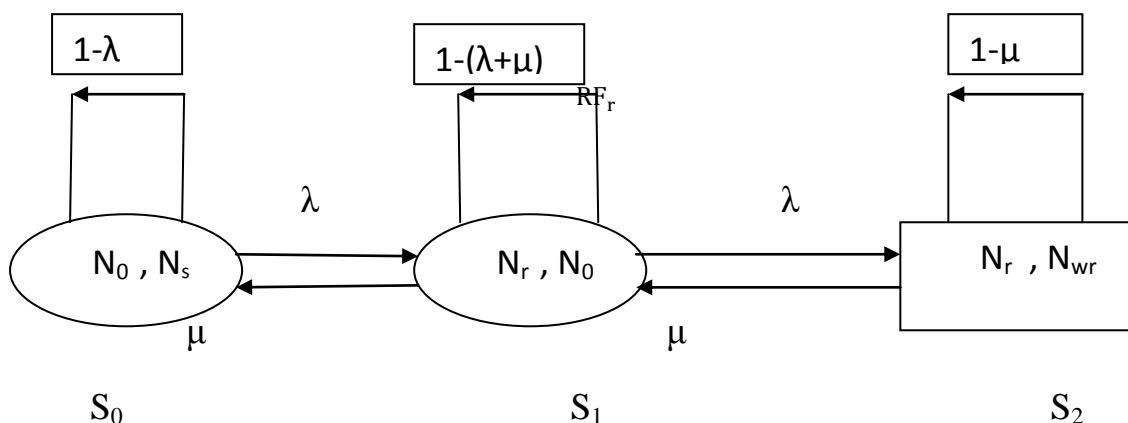
1. The system consists of a two-units in series in which one unit is operational whereas the other units is in standby mode.
2. Whenever a working unit fails, it is immediately taken over by standby unit and the failed unit is simultaneously sent for repair.
3. There is a single repair facility which repairs the units on first come first serve basis.
4. After repair any unit works as a new unit.
5. Switching system is perfect and switchover is perfect.

6. Failure times are identically distributed exponential random variable whereas the repair time is exponentially distributed
7. In State one both the components are operable.
8. In State two one component is in failed mode whereas the other component is operable.
9. In State three both the components are in the failed state

**Notations and Symbols**

$\lambda$ = Failure rate of Operative unit  
 ;  $\mu$ = repair rate of failed unit  
 $N_0$ = Unit in Operative mode ;  
 $N_s$ = Unit in Standby mode  
 $N_r$ = Unit in repair mode ;  
 $N_{wr}$ =Unit waiting for repair

**Upstate :** [  $S_0, S_1$  ] **Downstate :** [  $S_2$  ]



**State Transition Diagram**

**Transition Probabilities and mean sojourn times**

Simple probabilistic considerations give the following expressions for the non-zero elements:

$$p_{ij} = Q_{ij}(\infty) = \int_0^{\infty} q_{ij}(t) dt$$

With respect to the above model, we have the following results

$$Q_{00}(t) = \int_0^t e^{-\lambda t} (1-\lambda) e^{-(1-\lambda)t} dt ;$$

$$Q_{01}(t) = \int_0^t \lambda e^{-\lambda t} e^{-(1-\lambda)t} dt$$

$$Q_{10}(t) = \int_0^t \mu e^{-\mu t} e^{-\lambda t} e^{-[(\lambda+\mu)t]} dt ;$$

$$Q_{11}(t) = \int_0^t [1 - (\lambda + \mu)] e^{-[(\lambda+\mu)t]} e^{-(\lambda+\mu)t} dt$$

$$Q_{12}(t) = \int_0^t \lambda e^{-\lambda t} e^{-[(\lambda+\mu)t]} e^{-\mu t} dt ;$$

$$Q_{21}(t) = \int_0^t \mu e^{-\mu t} e^{-(1-\mu)t} dt$$

$$Q_{22}(t) = \int_0^t (1-\mu) e^{-(1-\mu)t} e^{-\mu t} dt$$

Taking  $\lim_{t \rightarrow \infty}$ , we get

$$p_{00} = 1 - \lambda ; \quad p_{01} = p_{12} = \lambda ; \quad p_{10} = p_{21} = \mu ;$$

$$p_{11} = 1 - (\lambda + \mu) ; \quad p_{22} = 1 - \mu$$

### MTBF Analysis :

We have

$$p_i(t) = \Pr\{X(t) = i : X(0) = 0\}, i = 0,1,2$$

$$p_0(t + \Delta t) = \Pr\{X(t + \Delta t) = 0 : X(0) = 0\}$$

$$= \sum_{j=0}^2 \Pr\{X(t + \Delta t) = 0, X(t) = j : X(0) = 0\}$$

Using  $P(A \cap B) = P(A/B)P(B)$ , we get

$$p_0(t + \Delta t) = \sum_{j=0}^2 \Pr\{X(t + \Delta t) = 0 : X(t) = j, X(0) = 0\} \Pr\{X(t) = j : X(0) = 0\}$$

$$= \sum_{j=0}^2 \Pr\{X(t + \Delta t) = 0 : X(t) = j\} p_j(t)$$

$$= \Pr\{X(t + \Delta t) = 0 : X(t) = 0\} p_0(t) + \Pr\{X(t + \Delta t) = 0 : X(t) = 1\} p_1(t)$$

$$+ \Pr\{X(t + \Delta t) = 0 : X(t) = 2\} p_2(t)$$

$$p_0(t + \Delta t) = (1 - \lambda \Delta t) p_0(t) + \mu \Delta t p_1(t) + O(\Delta t)$$

$$p_0(t + \Delta t) - p_0(t) = -\lambda \Delta t p_0(t) + \mu \Delta t p_1(t) + O(\Delta t)$$

Dividing by  $\Delta t$  and taking  $\lim_{\Delta t \rightarrow 0}$  both the sides, we get

$$\lim_{\Delta t \rightarrow 0} \frac{p_0(t + \Delta t) - p_0(t)}{\Delta t} = -\lambda p_0(t) + \mu p_1(t) + \lim_{\Delta t \rightarrow 0} \frac{O(\Delta t)}{\Delta t}$$

, we get

$$p_0'(t) = -\lambda p_0(t) + \mu p_1(t) \tag{1}$$

Similarly, developing the other relation for  $p_1'(t)$ , we get

$$p_1'(t) = \lambda p_0(t) - (\lambda + \mu) p_1(t) \tag{2}$$

Taking Laplace transforms of equations (1) and (2) and using Cramer's rule and again taking Inverse Laplace transform and using  $\lambda = k_1 + k_3$  and  $\mu = k_2 + k_3$ , we get the following results :

$$p_0(t) = \frac{(k_1 + k_2 + k_3 + s_1) e^{s_1 t} - (k_1 + k_2 + k_3 + s_2) e^{s_2 t}}{s_1 - s_2}$$

and

$$p_1(t) = \frac{(k_1 + k_3)(e^{s_1 t} - e^{s_2 t})}{s_1 - s_2}$$

Using  $R(t) = p_0(t) + p_1(t)$ , we get the following result for the Reliability

$$R(t) = \frac{(s_1 e^{s_2 t} - s_2 e^{s_1 t})}{s_1 - s_2}$$

$$\text{And } MTBF = \int_0^{\infty} R(t) dt = -\frac{s_1 + s_2}{s_1 s_2} = \frac{2k_1 + k_2 + 2k_3}{k_1(k_1 + k_3)}$$

### Availability Analysis:

Developing the similar expressions for  $p_0'(t)$ ,  $p_1'(t)$  &  $p_2'(t)$ , we get

$$p_0'(t) = -\lambda p_0(t) + \mu p_1(t)$$

$$p_1'(t) = \lambda p_0(t) - (\lambda + \mu) p_1(t)$$

$$p_2'(t) = \lambda p_1(t) - \mu p_2(t)$$

Similarly, taking Laplace transform of the above three equations and using Cramer's rule and taking  $\lambda = k_1 + k_3$  and  $\mu = k_2 + k_3$ , we get the following results for point wise availability of the system as

$$A(t) = p_0(t) + p_1(t) = 1 - p_2(t)$$

$$= \frac{s_1 s_2 - \frac{k_1(k_1 + k_3)}{s_1 - s_2} [s_1(1 - e^{s_2 t}) - s_2(1 - e^{s_1 t})]}{s_1 s_2}$$

And the steady-state availability of the system is given by the expression:

$$A_{\infty} = \lim_{t \rightarrow \infty} A(t) = 1 - \frac{k_1(k_1 + k_3)}{s_1 s_2} = \frac{(k_2 + 2k_3)(k_1 + k_2 + 2k_3)}{(k_2 + 2k_3)^2 + k_1(k_1 + k_2 + 3k_3)}$$

The mean down time of the system is given by the expression :

$$MDT = \frac{MTBF(1 - A_{\infty})}{A_{\infty}} \quad \text{Where}$$

$$MTBF = \frac{(2k_1 + k_2 + 2k_3)}{k_1(k_1 + k_3)} \quad \text{and}$$

$$A_{\infty} = \frac{(k_2 + 2k_3)(k_1 + k_2 + 2k_3)}{(k_2 + 2k_3)^2 + k_1(k_1 + k_2 + 3k_3)}$$

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